

Instructions for Testing of Skeleton Technologies' Supercapacitors

General testing considerations

Commonly, constant current testing is done within voltage range of 1.5V to 3.0V. The maximum allowed continuous current is 308A ($\Delta T = 40^\circ\text{C}$) and maximum peak current for 1s is 3.5kA. The maximum allowed application temperature is $+65^\circ\text{C}$ as higher temperature may damage the supercapacitors. Rated voltage ($V_r = 3.0\text{V}$) should not be exceeded and polarity must not be reversed.

Application temperature

The application temperature range for Skeleton supercapacitors is -40°C to $+65^\circ\text{C}$.

Capacitance

For capacitance estimation, constant current charge-discharge cycles are measured within voltage range of 3.0V to 1.5V at an applied current of 10mA/F (Figure 1). The testing temperature for rated capacitance estimation is $23 \pm 2^\circ\text{C}$. For other testing temperatures, climatic chamber should be used and temperature stabilization allowed for several hours.

Example: for 3400F supercapacitor the charge-discharge current is $0.010\text{A/F} \times 3400\text{F} = 34.0\text{A}$. The capacitance value is calculated from the discharge cycle according to equation:

$$C = \frac{I \times (t_2 - t_1)}{V_1 - V_2}$$

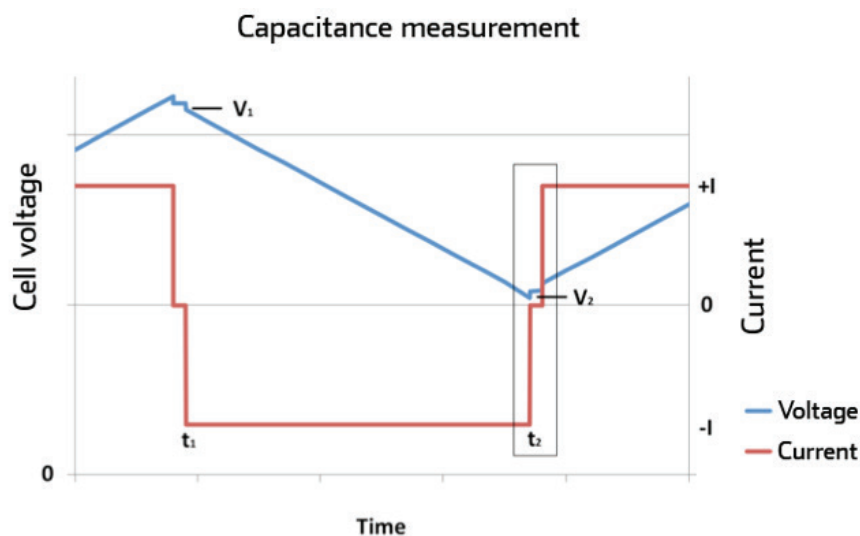


Figure 1. Constant current charge/discharge profiles for capacitance and ESR estimation.

Internal resistance (Electrochemical Series Resistance, ESR)

Supercapacitor ESR estimation is complicated by the fact that voltage is influenced by both the resistance and the capacitance of the device. Additionally, charge redistribution effects occur due to the restricted electrolyte mobility inside the electrode porosity and the accompanying uneven surface charge regions.

Both DC (direct current) and AC (alternating current) -based electrochemical testing methods are widely applied for estimation of ESR. Different testing methods result in useful information from specific application point of view. International testing standards exist (e.g., IEC62391), indicating suggested testing methods according to applications. However, supercapacitor producers often present ESR values obtained by adaptations of testing methods according to equipment limitations and preferred testing techniques.

DC methods for estimation of ESR

The ESR values for an supercapacitor can be determined from the abovementioned constant current charge-discharge cycles measured at 10 mA/F. After discharge, the spontaneous rise in voltage is monitored during a current-cut period of 1 second (Figure 2).

The “DC 10ms ESR” and “DC 1s ESR” are determined according to equations:

$$ESR_{DC,10ms} = \frac{V_3 - V_2}{I}$$

$$ESR_{DC,1s} = \frac{V_4 - V_2}{I}$$

where V_2 is 1.5 V, V_3 is measured at $t_3 = 0.01s$ after current-cut and V_4 is measured at $t_4 = 1s$ after current-cut.

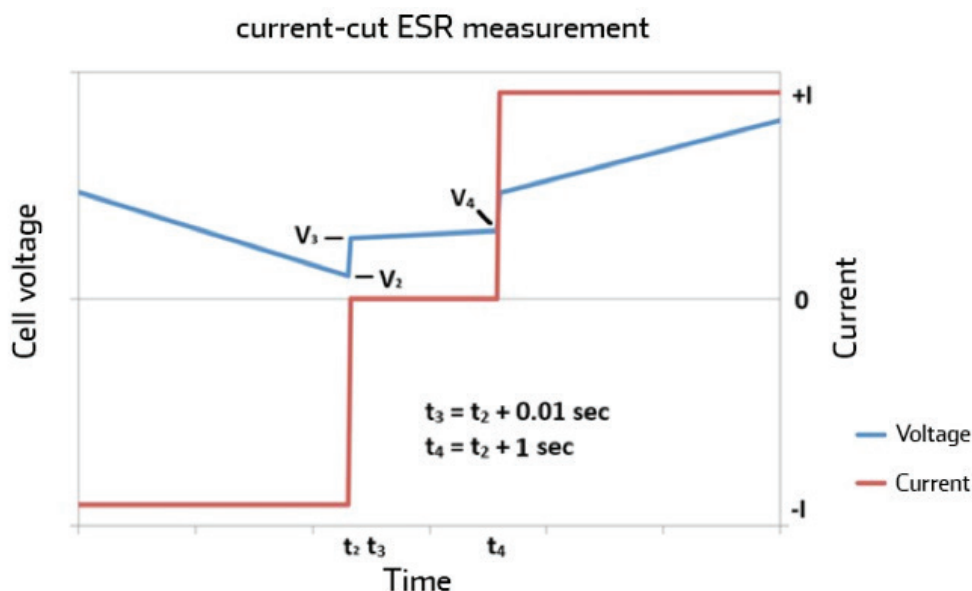


Figure 2. Inset of constant current discharge profile section in Figure 1 for ESR estimation.

Depending on the testing equipment limitations, another DC method can be used for estimating the “DC 10ms ESR”, where 10 continuous DC current pulses of 10ms duration are generated and the voltage response is monitored (Figure 3). Typically, 10mA/F pulse current value is applied*.

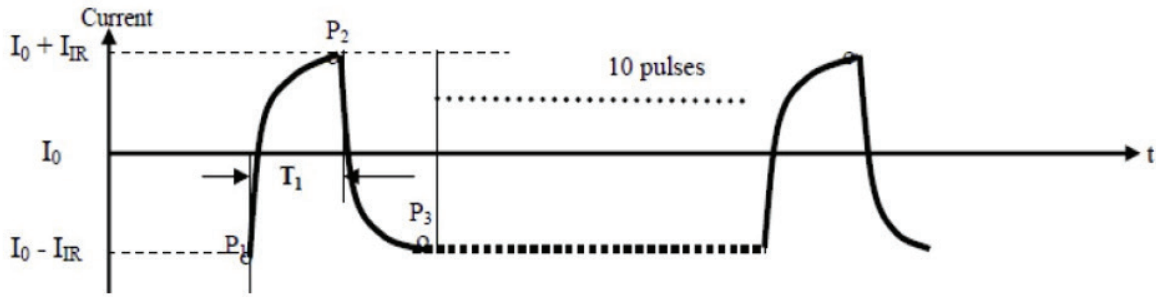


Figure 3. Current pulse measurement profile for nominal ESR estimation.

The “DC 10ms ESR” is calculated according to equation:

$$ESR_{DC,10ms} = \text{average} \left(\frac{\text{voltage at } P_2 - \text{voltage at } P_3}{2I} \right)$$

*If supercapacitor has very low resistance, then up to 100 mA/F pulse current should be used. Different current pulses should be tested to evaluate the equipment accuracy for this test – same ESR value should be obtained from pulses of different current. If lower current pulse gives different value, then higher current should be selected.

Either of the “DC 10ms ESR” methods are acceptable for the performance testing. Note: If pulse method is chosen for “DC 10ms ESR” estimation, the order of measurements is the opposite to current-cut measurements. Nominal ESR should be measured after measuring the “DC 1s ESR” (t4 in Figure 2).

IEC62391 method for estimation of ESR

The IEC62391 standard based method for estimation of supercapacitor ESR is described in the respective standard documentation:

<https://webstore.iec.ch/publication/23581>

Energy

The stored energy (E_{stored}) is calculated from the rated voltage (V_r) and the capacitance (C):

$$E_{\text{stored}} = \frac{\frac{1}{2} CV^2}{3,600}$$

Power

The power performance of the supercapacitor is estimated from the rated voltage (V_r) and the internal resistance (ESR). The maximum power (P_{\max}) is calculated according to equation:

$$P_{\max} = \frac{V^2}{4 \times \text{ESR}}$$

Maximum specific power (kW/kg) and power density (kW/L) are determined by dividing the maximum power value by the supercapacitor mass or volume.

Self-discharge

Self-discharge is spontaneous process of voltage loss during a specified period when a capacitor has been set to open-circuit condition after charging. Self-discharge is estimated by following international standard IEC62391, according to which the charging time (CCCV phase) shall be 8h, including maximum 30 min charge-up time to reach 95% of the rated voltage (3.0V), after which the current is interrupted, and the cell is kept at ambient temperature. After 72 hours, the open circuit voltage is measured. The decay in voltage ($V_r - V_{72h}$) is the characteristic self-discharge.

Leakage current

Leakage current of supercapacitor is specified as the current needed for maintaining the supercapacitor at rated voltage (3.0V) at $23 \pm 2^\circ\text{C}$ (if not specified otherwise). Leakage current is estimated by following international standard IEC62391, according to which the maximum charging time is 30 min charge-up time to reach 95% of the rated voltage (3.0V), or another fixed voltage, and by keeping this constant voltage over a period of 72h, during which the leakage current declines to a steady-state value. The measured value at 72h is the characteristic leakage current.

Thermal

Thermal resistance (R_{th}) is calculated according to equation:

$$R_{th} = \frac{\Delta T}{\text{ESR} \times I^2}$$

ΔT is the case-to-ambient temperature difference at applied current I . ESR is the total resistance at applied current I . ΔT should be measured at constant ambient temperature and with minimal air flow to avoid cooling by convection. The cell should be suspended in air from the cell's terminal ends to avoid cooling by conduction.

The maximum application current for a specified rise in temperature (ΔT) can then be calculated from the following equation:

$$I_{\max} = \sqrt{\frac{\Delta T}{\text{ESR} \times R_{th}}}$$

Thermal capacitance (C_{th}) is determined from the ratio of energy emitted as heat during cooldown ($I = 0A$) from a stabilized temperature reached during cycling at I , and the cell's temperature difference before and after cooldown.